

**FOR PTO-1449 (Mod. 2/21)**

**LIST OF PATENTS AND PUBLICATIONS FOR  
APPLICANTS INFORMATION DISCLOSURE  
STATEMENT**

(Use several sheets if necessary)

**ATTY. DOCKET NO.**

**SERIAL NO.**

3521 125

09/536.927

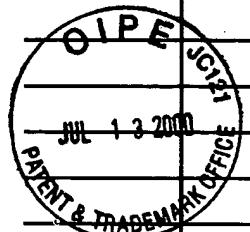
**APPLICANT**  
ANDREW M. HAWRYLUK, et al.

**FILING DATE**  
March 27, 2000

**GROUP** 2822

**REFERENCE DESIGNATION**

**U.S. PATENT DOCUMENTS**



~~RECEIVED~~

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## **FOREIGN PATENT DOCUMENTS**

**OTHER**

**ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

TMT	B	Michael O. Thompson and T. J. Renk, Numerical Modeling and Experimental Measurements of Pulsed Ion Beam surface Treatment, Mat. Res. Soc. Symp. Proc. Vol. 504, 1998, pp 33-38
TMT	C	T. J. Renk, et al., Improvement of surface properties by modification and alloying with high-power ion beams, Physics of Plasmas, volume 5, number 5, May 1998, pp 2144-2150

**EXAMINER**

**DATE CONSIDERED**

T. M. Thomas

W/16/01

**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.